

**Search Notes**

Application/Control No.

10/725,369

Examiner

Richard Chan

Applicant(s)/Patent under  
Reexamination

SUGANUMA, HISASHI

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	296	6/23/2006	RC
455	266	6/23/2006	RC
455	222	6/23/2006	RC
375	104	6/23/2006	RC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
keyword: absolute adj value near4 maximum	6/23/2006	RC